

Search Notes

Application/Control No.

10/768,439

Examiner

Hashem Farrokh

Applicant(s)/Patent under
Reexamination

HIGAKI ET AL.

Art Unit

2187

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |
| | | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 711 | 162 | 1/30/2006 | HF |
| 707 | 204 | 1/30/2006 | HF |
| | | | |
| | | | |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|---|-----------|------|
| <i>Inventor</i> PALM and East Search Conducted | 1/30/2006 | HF |
| Brian Peugh Consulted | 1/30/2006 | HF |
| Search: US EPO JPO DEWENT IBM | 1/30/2006 | HF |
| 711/4,112,114-115,161-162 (Text Search see Printout) | 1/30/2006 | HF |
| 707/ALL (Text Search see Printout) | 1/30/2006 | HF |
| 709/203,208,219,241 (Text Search see Printout) | 1/30/2006 | HF |
| | | |
| | | |